

Search Notes

Application/Control No.

10/565,975

Examiner

Binh X. Tran

Applicant(s)/Patent under Reexamination

CHOI, IN-HWAN

Art Unit

1792

SEARCHED

Class	Subclass	Date	Examiner
427	255.7	4/10/2008	BT
427	255.29	4/10/2008	BT
427	255.28	4/10/2008	BT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search keywords and inventor's name using databases in EAST	4/10/2008	BT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner